

AOT428

N-Channel Enhancement Mode Field Effect Transistor

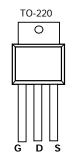


General Description

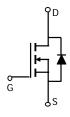
The AOT428 uses advanced trench technology and design to provide excellent R_{DS(ON)} with low gate charge. This device is suitable for use in PWM, load switching and general purpose applications. Standard Product AOT428 is Pb-free (meets ROHS & Sony 259 specifications). AOT428L is a Green Product ordering option. AOT428 and AOT428L are electrically identical.

Features

$$\begin{split} &V_{DS} \; (V) = 75 V \\ &I_{D} = 80 A \quad (V_{GS} = 10 V) \\ &R_{DS(ON)} < 11 \; m\Omega \; (V_{GS} = 10 V) \end{split}$$



Top View Drain Connected to Tab



Absolute Maximum Ratings T _A =25°C unless otherwise noted								
Parameter		Symbol	Maximum	Units				
Drain-Source Voltage		V_{DS}	75	V				
Gate-Source Voltage		V_{GS}	±30	V				
Continuous Drain	T _C =25°C		80					
Current ^G	T _C =100°C	I_D	57	Α				
Pulsed Drain Current C		I _{DM}	300					
Avalanche Current ^C		I _{AR}	60	А				
Repetitive avalanche energy L=0.1mH ^C		E _{AR}	180	mJ				
	T _C =25°C	D	115	W				
Power Dissipation ^B	T _C =100°C	P _D	58	VV				
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 175	°C				

Thermal Characteristics								
Parameter		Symbol	Тур	Typ Max l				
Maximum Junction-to-Ambient ^A	Steady-State	$R_{\theta JA}$	60	75	°C/W			
Maximum Junction-to-Case ^B	Steady-State	$R_{\theta JC}$	0.7	1.3	°C/W			

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Parameter Conditions		Тур	Max	Units				
STATIC PARAMETERS										
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250uA, V _{GS} =0V	75			V				
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V		0.02	1	μΑ				
		T _J =55°C	5°C		5					
I _{GSS}	Gate-Body leakage current	$V_{DS}=0V$, $V_{GS}=\pm30V$			100	nA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2	3.4	4.5	V				
I _{D(ON)}	On state drain current	V_{GS} =10V, V_{DS} =5V	200			Α				
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =10V, I_D =30A		9.1	11	mΩ				
		T _J =12	5°C	15.5	20					
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =30A		100		S				
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.7	1	V				
I _S	Maximum Body-Diode Continuous Current				55	Α				
DYNAMIC	PARAMETERS									
C _{iss}	Input Capacitance			3790	4900	pF				
Coss	Output Capacitance	V_{GS} =0V, V_{DS} =30V, f=1MHz		321	420	pF				
C_{rss}	Reverse Transfer Capacitance	7		222	290	pF				
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz		1.25	1.5	Ω				
SWITCHI	NG PARAMETERS									
Q _g (10V)	Total Gate Charge			65	85	nC				
Q_{gs}	Gate Source Charge	V_{GS} =10V, V_{DS} =30V, I_{D} =30A		23	30	nC				
Q_{gd}	Gate Drain Charge	1		23.5	31	nC				
t _{D(on)}	Turn-On DelayTime			20	26	ns				
t _r	Turn-On Rise Time	$V_{GS}=10V, V_{DS}=30V, R_{L}=1\Omega,$		48	63	ns				
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		30	40	ns				
t _f	Turn-Off Fall Time	7		10	13	ns				
t _{rr}	Body Diode Reverse Recovery Time	I _F =30A, dI/dt=100A/μs		43	56	ns				
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =30A, dI/dt=100A/μs		88	114	nC				

A: The value of R $_{\theta JA}$ is measured with the device in a still air environment with T $_{A}$ =25°C.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =175°C.

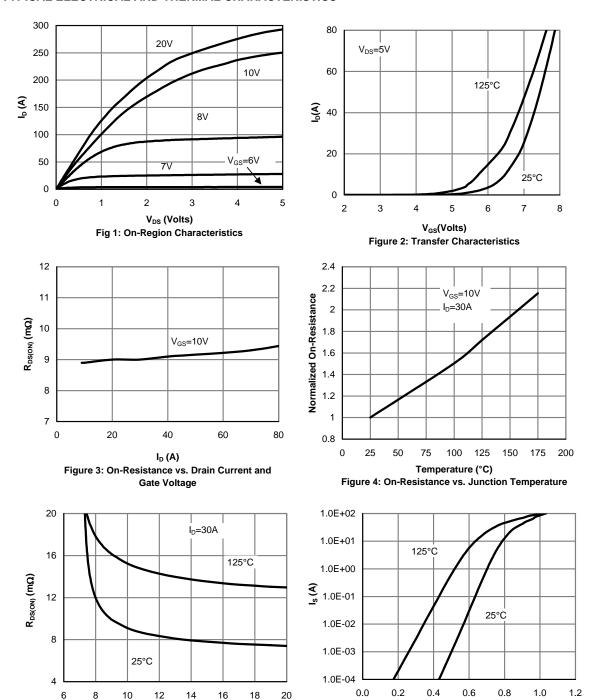
D. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to case R $_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =175°C.

G. The maximum current rating is limited by bond-wires.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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V_{GS} (Volts)

Figure 5: On-Resistance vs. Gate-Source Voltage

V_{SD} (Volts)

Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

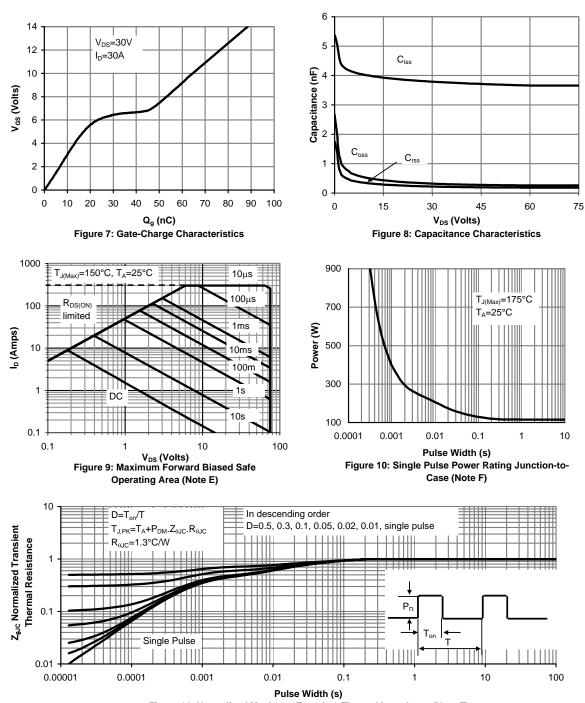


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

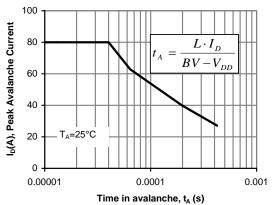


Figure 12: Single Pulse Avalanche capability

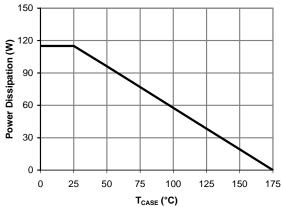


Figure 13: Power De-rating (Note B)

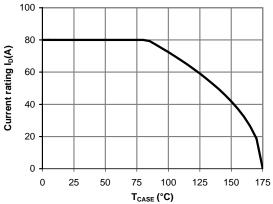


Figure 14: Current De-rating (Note B)